

ANALOG DEVICES/ PMI DIV

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ABSOLUTE MAXIMUM RATINGS

Supply Voltage (V_{CC}) $\pm 22V$
 Input Voltage Range (V_{IN}) $\pm V_{CC}$
 Differential Input Voltage Range $\pm 30V$
 Output Short-Circuit Duration (Note 1)
 Lead Temperature (Soldering, 60 sec) $+300^{\circ}C$
 Storage Temperature Range $-65^{\circ}C$ to $+150^{\circ}C$
 Junction Temperature (T_J) $+150^{\circ}C$
 Maximum Power Dissipation (P_D) (Note 2) 500mW

RECOMMENDED OPERATING CONDITIONS

Supply Voltage Range $\pm 4.5V$ to $\pm 20V$
 Ambient Temperature Range $-55^{\circ}C$ to $+125^{\circ}C$

T-79-06-10

NOTES:

- Output may be shorted to ground indefinitely at $V_S = \pm 15V$, $T_A = 25^{\circ}C$. Temperature and/or supply voltages must be limited to ensure dissipation rating is not exceeded.
- Maximum power dissipation versus ambient temperature.

ELECTRICAL CHARACTERISTICS at $\pm 4.5V \leq V_{CC} \leq \pm 20V$ and $-55^{\circ}C \leq T_A \leq 125^{\circ}C$, $R_S = 50\Omega$ unnullled, unless otherwise noted.

PARAMETER	SYMBOL	CONDITIONS	01 LIMITS		02 LIMITS		UNITS
			MIN	MAX	MIN	MAX	
Input Offset Voltage	V_{IO}	$T_A = 25^{\circ}C$ (Notes 1, 2)	-25 -80	25 80	-75 -200	75 200	μV
Input Offset Voltage Temperature Sensitivity	$\Delta V_{IO}/\Delta T$	(Note 1)	-0.6	0.6	-1.3	1.3	$\mu V/^{\circ}C$
Input Bias Current	$+I_{IB}$	$T_A = 25^{\circ}C$ (Note 1)	-2 -4	2 4	-3 -6	3 6	nA
	$-I_{IB}$	$T_A = 25^{\circ}C$ (Note 1)	-2 -4	2 4	-3 -6	3 6	
Input Offset Current	I_{IO}	$T_A = 25^{\circ}C$ (Note 1)	-2 -4	2 4	-2.8 -5.6	2.8 5.6	nA
Power Supply Rejection Ratio	+PSRR	$+V_{CC} = 20V$ to $5V$, $-V_{CC} = -15V$ $T_A = 25^{\circ}C$	—	10	—	10	$\mu V/V$
	-PSRR	$+V_{CC} = 15V$, $-V_{CC} = -20V$ to $-5V$ $T_A = 25^{\circ}C$	—	10	—	10	
	+PSRR	$+V_{CC} = 20V$ to $5V$, $-V_{CC} = -15V$	—	20	—	20	
	-PSRR	$+V_{CC} = 15V$, $-V_{CC} = -20V$ to $-5V$	—	20	—	20	
	PSRR	$V_{CC} = \pm 4.5V$ to $\pm 20V$ $T_A = 25^{\circ}C$	—	10	—	10	
		$V_{CC} = \pm 4.5V$ to $\pm 20V$	—	20	—	20	

NOTES:

- Tested at $V_{CM} = 0$, $V_{CC} = \pm 15V$.
- Due to the inherent warm-up drift, testing shall occur no sooner than three (3) minutes after application of power.

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OPERATIONAL AMPLIFIERS/BUFFERS



ELECTRICAL CHARACTERISTICS at $\pm 4.5V \leq V_{CC} \leq \pm 20V$ and $-55^\circ C \leq T_A \leq +125^\circ C$, $R_S = 50\Omega$ unnull'd, unless otherwise noted. *Continued*

PARAMETER	SYMBOL	CONDITIONS	01 LIMITS		T-79-06-10 02 LIMITS		UNITS
			MIN	MAX	MIN	MAX	
Common-Mode Rejection Ratio	CMRR	$V_{CM} = \pm 13V$, $T_A = +25^\circ C$, $V_{CC} = \pm 15V$	110	—	110	—	dB
		$V_{CM} = \pm 13V$, $V_{CC} = \pm 15V$	106	—	106	—	
Adjustment for Input Offset	$V_{IO} \text{ Adj (+)}$	$T_A = +25^\circ C$ (Note 1)	0.5	—	0.5	—	mV
	$V_{IO} \text{ Adj (-)}$	$T_A = +25^\circ C$ (Note 1)	—	0.5	—	0.5	
Output Short-Circuit Current	$I_{OS(+)}$	$t \leq 25ms$ (Notes 1, 3) $T_A = +25^\circ C$, $+125^\circ C$	-65	—	-65	—	mA
		$T_A = -55^\circ C$	-70	—	-70	—	
	$I_{OS(-)}$	$t \leq 25ms$ (Notes 1, 3) $T_A = +25^\circ C$, $+125^\circ C$	—	65	—	65	
		$T_A = -55^\circ C$	—	70	—	70	
Supply Current	I_{CC}	$T_A = +25^\circ C$	—	4	—	4	mA
		(Note 1)	—	5	—	5	
Output Voltage Swing (Minimum)	V_{OP}	$R_L = 1k\Omega$ (Note 1)	-10	10	-10	10	V
		$R_L = 2k\Omega$ (Note 1)	-12	12	-12	12	
Open-Loop Voltage Gain (Single-Ended)	A_{VS}	$T_A = +25^\circ C$	300	—	200	—	V/mV
		(Notes 1, 2)	200	—	150	—	
Slew Rate	$SR(+)$, $SR(-)$	$V_{IN} = 10V$, $T_A = +25^\circ C$, (Note 1)	0.08	—	0.08	—	V/ μs
Input Noise Voltage Density	e_n	$f_O = 10Hz$	—	18	—	18	nV/ $\sqrt{Hz}$
		$f_O = 100Hz$, $T_A = +25^\circ C$ (Note 1)	—	14	—	14	
		$f_O = 1kHz$	—	12	—	12	
Low Frequency Input Noise Voltage	e_{np-p}	$f = 0.1Hz$ to $10Hz$, $T_A = 25^\circ C$, (Note 1)	—	0.6	—	0.6	μV_{p-p}

NOTES:

1. Tested at $V_{CM} = 0$, $V_{CC} = \pm 15V$.
2. $V_{OUT} = 0$ to $+10V$ for $A_{VS(+)}$ and $V_{OUT} = 0$ to $-10V$ for $A_{VS(-)}$. $R_L = 2k\Omega$.
3. Continuous short-circuit limits are considerably less than the indicated test limits, since maximum power dissipation cannot be exceeded.